

Vishay Siliconix

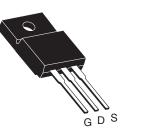
RoHS

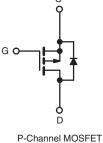
COMPLIANT

Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	- 200				
R _{DS(on)} (Ω)	V _{GS} = - 10 V	0.80			
Q _g (Max.) (nC)	29				
Q _{gs} (nC)	5.4				
Q _{gd} (nC)	15				
Configuration	Single				

TO-220 FULLPAK





FEATURES

- Isolated Package
- High Voltage Isolation = 2.5 kV_{RMS} (t = 60 s, f = 60 Hz)
- Sink to Lead Creepage Distance = 4.8 mm
- P-Channel
- Dynamic dV/dt Rating
- Low Thermal Resistance
- Lead (Pb)-free Available

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 FULLPAK eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heatsink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The FULLPAK is mounted to a heatsink using a single clip or by a single screw fixing.

ORDERING INFORMATION	
Package	TO-220 FULLPAK
Lead (Pb)-free	IRFI9630GPbF
	SiHFI9630G-E3
SnPb	IRFI9630G
	SiHFI9630G

ABSOLUTE MAXIMUM RATINGS T	C = 25 °C, u	nless otherw	vise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	- 200	- V	
Gate-Source Voltage			V _{GS}	± 20		
Continuous Drain Current	V _{GS} at - 10 V -	T _C = 25 °C	- I _D	- 4.3		
		$T_C = 100 ^{\circ}C$		- 2.7	А	
Pulsed Drain Current ^a			I _{DM}	- 17	1	
Linear Derating Factor				0.28	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	480	mJ	
Repetitive Avalanche Current ^a			I _{AR} - 4.3		A	
Repetitive Avalanche Energy ^a			E _{AR}	3.5	mJ	
Maximum Power Dissipation	T _C =	25 °C	P _D 35		W	
Peak Diode Recovery dV/dt ^c			dV/dt	- 5.0	V/ns	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to + 150	*0		
Soldering Recommendations (Peak Temperature)	for 10 s			300 ^d	- °C	
Mounting Torque	6 20 or 1	6-32 or M3 screw		10	lbf ⋅ in	
	0-32 OF M3 SCIEW		F	1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = -50$ V, starting $T_J = 25$ °C, L = 38 mH, $R_G = 25 \Omega$, $I_{AS} = -4.3$ A (see fig. 12).

c. $I_{SD} \leq$ - 6.5 A, dI/dt \leq 120 A/µs, $V_{DD} \leq V_{DS}$, $T_J \leq$ 150 °C.

d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply

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THERMAL RESISTANCE RA	TINGS								
PARAMETER	SYMBOL	TYP.		MAX.		UNIT			
Maximum Junction-to-Ambient	R _{thJA}	- 65							
Maximum Junction-to-Case (Drain)	R _{thJC}	- 3.6				°C/W			
SPECIFICATIONS $T_J = 25 \ ^{\circ}C$,					-	1	r		
PARAMETER	SYMBOL	TES	T CONDITI	ONS	MIN.	TYP.	MAX.	UNIT	
Static		I				1	1	1	
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	0 V, I _D = 2	50 μΑ	- 200	-	-	V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C,	I _D = 1 mA	-	- 0.24	-	V/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	$V_{GS}, I_D = 2$	50 μΑ	- 2.0	-	- 4.0	V	
Gate-Source Leakage	I _{GSS}	$V_{GS} = \pm 20 \text{ V}$			-	-	± 100	nA	
Zero Gate Voltage Drain Current	Inco	$V_{DS} = -$	- 200 V, V _G	_S = 0 V	-	-	- 100		
Zero dale volage Brain ourient	IDSS	V _{DS} = - 160 V	- 160 V, V _{GS} = 0 V, T _J = 125 °C			-	- 500	μΑ	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D =	= - 2.6 A ^b	-	-	0.80	Ω	
Forward Transconductance	9 _{fs}	V _{DS} = -	50 V, I _D =	- 2.6 A ^b	2.4	-	-	S	
Dynamic									
Input Capacitance	C _{iss}		$\gamma = 0 \gamma$			700	-		
Output Capacitance	C _{oss}	V	V _{GS} = 0 V, V _{DS} = - 25 V,		-	200	-	_	
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	40	-	pF		
Drain to Sink Capacitance	С	t	f = 1.0 MHz	2	-	12	-	1	
Total Gate Charge	Qg				-	-	29		
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V		A, $V_{DS} = -160 V$, fig. 6 and 13 ^b	-	-	5.4	nC	
Gate-Drain Charge	Q _{gd}		see nç	J. 6 and 13°	-	-	15		
Turn-On Delay Time	t _{d(on)}	I			-	12	-		
Rise Time	tr		100 V, I _D =		-	27	-		
Turn-Off Delay Time	t _{d(off)}	$\begin{array}{l} R_{G} = 12\;\Omega, \; R_{D} = 15\;\Omega, \\ \text{see fig. 10}^{b} \end{array}$		-	28	-	ns		
Fall Time	t _f			-	24	-			
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-			
Internal Source Inductance	L _S			-	7.5	-	nH		
Drain-Source Body Diode Characteristic	s							•	
Continuous Source-Drain Diode Current	١ _S	MOSFET symbol showing the	MOSFET symbol showing the		-	-	- 4.3	A	
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	- 17			
Body Diode Voltage	V_{SD}	$T_J = 25 \ ^{\circ}C, \ I_S = - \ 4.3 \ A, \ V_{GS} = 0 \ V^b$		-	-	- 6.5	V		
Body Diode Reverse Recovery Time	t _{rr}	$T_J = 25 \ ^{\circ}C, I_F = -6.5 \ A, \ dl/dt = -100 \ A/\mu s^b$		-	200	300	ns		
Body Diode Reverse Recovery Charge	Q _{rr}			-	2.0	2.9	μC		
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D					_D)		

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

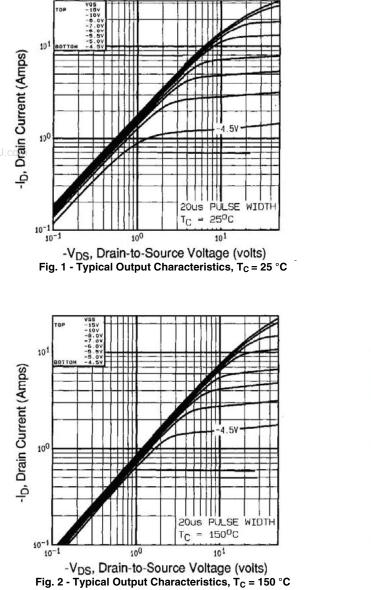
b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.

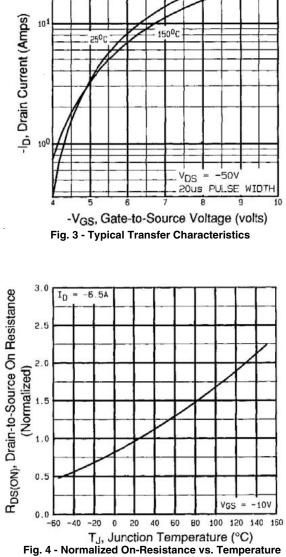


IRFI9630G, SiHFI9630G

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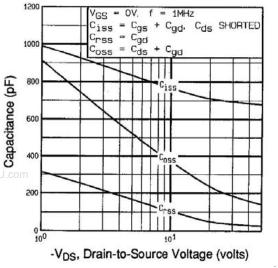


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

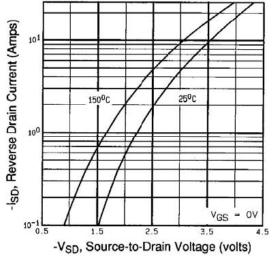


Fig. 7 - Typical Source-Drain Diode Forward Voltage

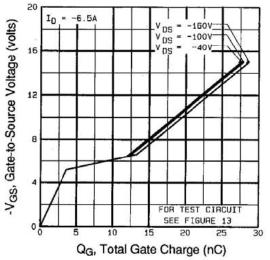
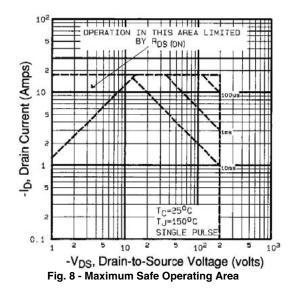


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage



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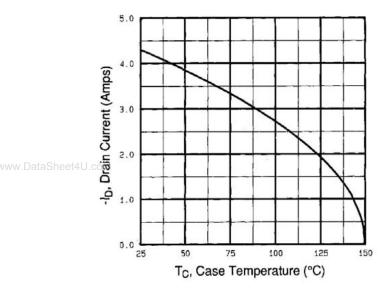


Fig. 9 - Maximum Drain Current vs. Case Temperature

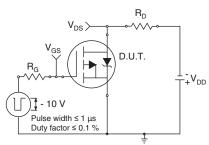


Fig. 10a - Switching Time Test Circuit

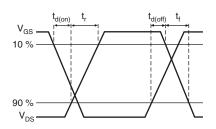
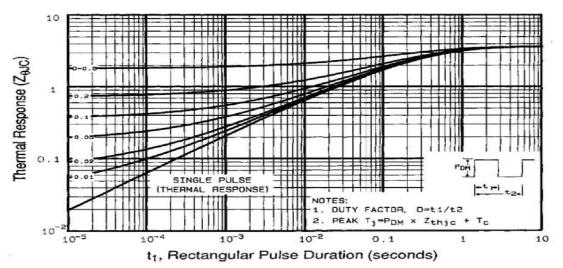
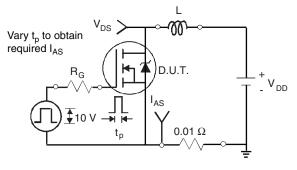
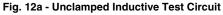


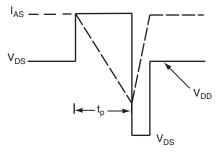
Fig. 10b - Switching Time Waveforms

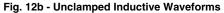








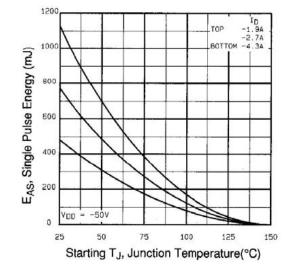




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Fig. 12c - Maximum Avalanche Energy vs. Drain Current

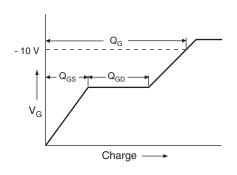
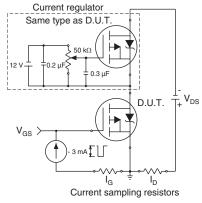


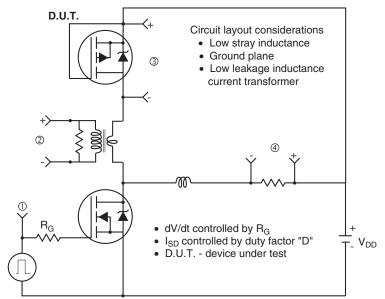
Fig. 13a - Basic Gate Charge Waveform





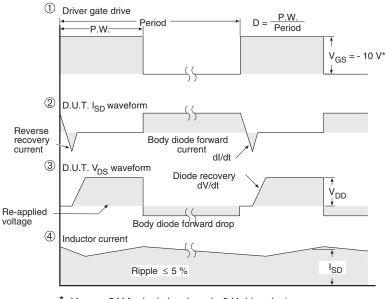


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Peak Diode Recovery dV/dt Test Circuit

• Compliment N-Channel of D.U.T. for driver







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